

[54] GRAIN MOISTURE TESTER

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Japan

[**] Term: 14 Years

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[58] Field of Search D10/56, 46, 47;
73/73-77, 336.5, 431

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[57] CLAIM

The ornamental design for grain moisture tester, as
shown and described.

DESCRIPTION

FIG. 1 is a front, top and right side perspective view of
grain moisture tester showing our new design, and
FIG. 2 is a front, bottom and right side perspective view
thereof.

The opposite sides, not shown, are substantially identi-
cal to FIGS. 1 and 2.

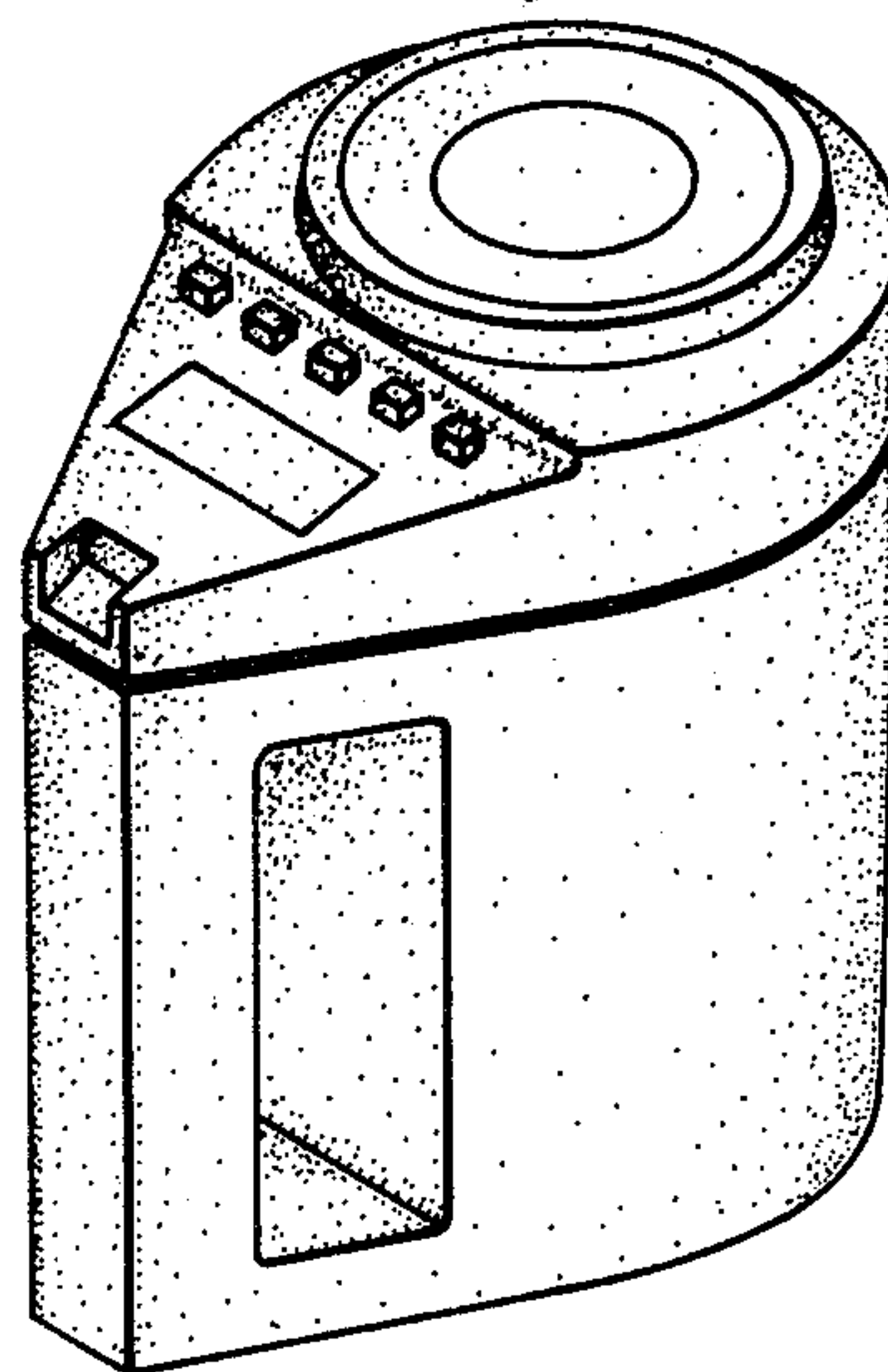


FIG. 1

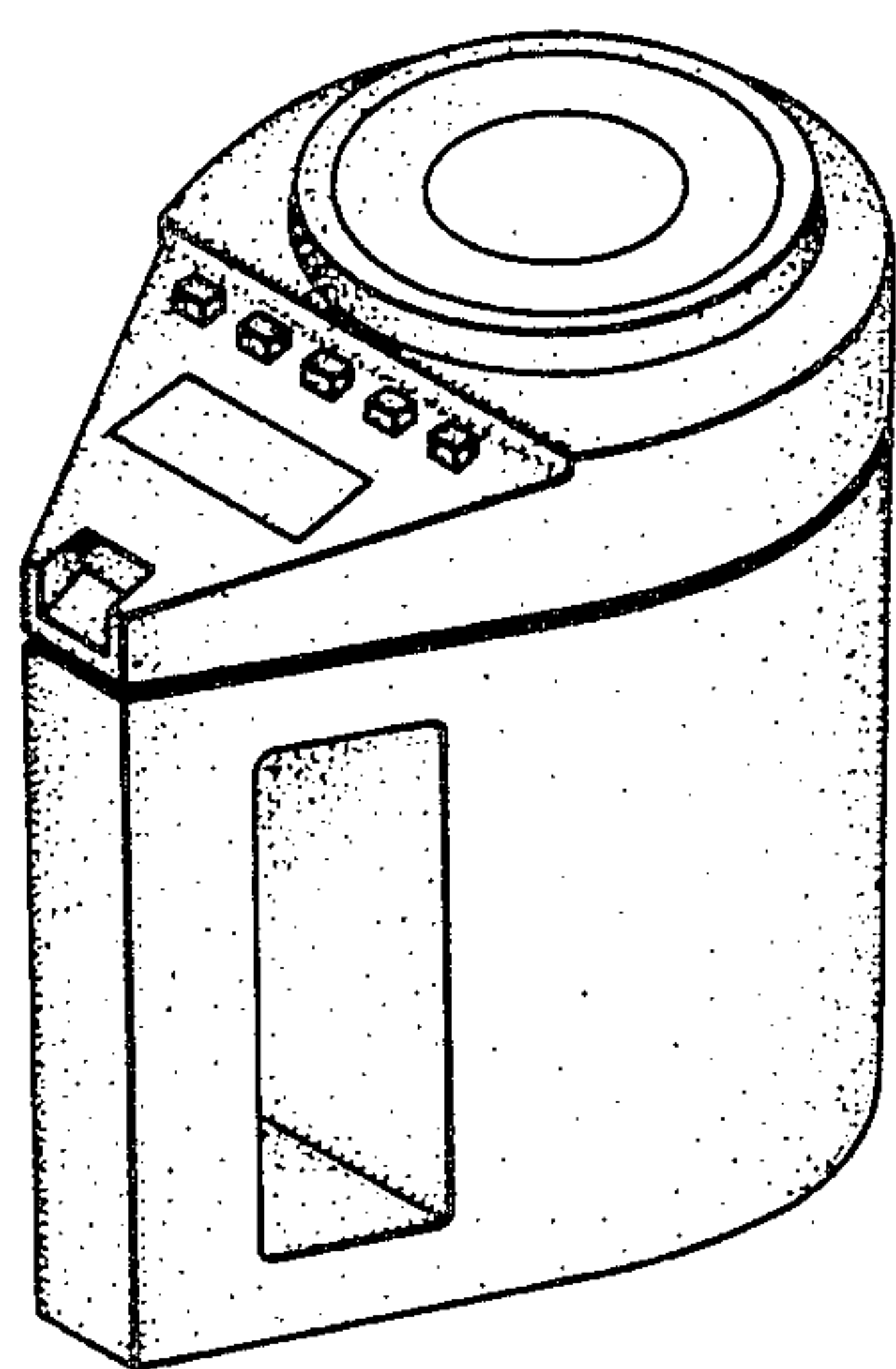


FIG. 2

